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	OF REFER	RENCES CITED BY APPLIC	CANT(S)	Applicant Nobuaki Fukasawa, et al.					
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U.S. PATENT DOCUMENTS *EXAMINED DOCUMENT NUMBER DATE NAME CLASS SUBCLASS FILING DATE IF APPROPRIATE **FILING DATE IF APPROPR									
EXAMINED I		DOCUMENT NUMBER	DATE	NAME	<u> </u>	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
PBT		5,764,911	06/09/98	Tezuka et al.	<u> </u>	395	200.53		
PBT		6,047,320	04/04/00	Tezuka et al.	L_	709	223	-	
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PBT		5,448,724	09/05/95	Mayashi		395	182.02		
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		DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
PBT	JP	05-274239	10/22/93	Japan		_	_	Abstract	
PBT	JP	05-53954	03/05/93	Japan				Abstract	
PBT	JP	10-294731	11/04/98	Japan			_	Abstract	
PBT	JP	10-303831	11/13/98	Japan		_		Abstract	
PBS	JP	07-55494	03/03/95	Japan		. —	_	Abstract	
PBT	JP	07-21135	01/24/95	Japan	L		_	Abstract	
PBT	JP	09-218835	08/19/97	Japan	L		—	Abstract	
PBI	JP	2001-43159	02/16/01	Japan			_	Abstract	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)									
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EXAMINER Philip Ivan DATE CONSIDERED 1-19-2006									

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.